

Notice of References Cited

Application/Control No.

10/708,941

Applicant(s)/Patent Under
Reexamination
YUAN ET AL.

Examiner

HIRDEPAL SINGH

Art Unit

2611

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0128744 A1	07-2003	Yeo et al.	375/147
*	B	US-2005/0003783 A1	01-2005	Ben-Ayun et al.	455/232.1
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	D	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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